BUV27

NPN Silicon Power Transistor

This device is designed for use in switching regulators and motor control.

Features

- Low Collection Emitter Saturation Voltage
- Fast Switching Speed
- These Devices are Pb-Free and are RoHS Compliant*

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector–Emitter Sustaining Voltage	V _{CEO}	120	Vdc
Collector–Emitter Breakdown Voltage	V _{CBO}	240	Vdc
Emitter-Base Voltage	V _{EBO}	7.0	Vdc
Collector Current - Continuous	I _C	12	Adc
Collector Current – Peak (Note 1)	I _{CM}	20	Adc
Base Current	I _B	4.0	Adc
Total Device Dissipation (T _C = 25°C) Derate above 25°C	P _D	70 0.56	W/°C
Operating and Storage Temperature	T _J , T _{stg}	- 65 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Pulse Test: Pulse Width = 5.0 ms, Duty Cycle ≤ 10%.

THERMAL CHARACTERISTICS

Rating	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case Junction-to-Ambient	$R_{ heta JC} \ R_{ heta JA}$	1.78 62.5	°C/W

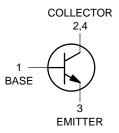


ON Semiconductor®

www.onsemi.com

POWER TRANSISTOR 12 AMPERES **120 VOLTS** 70 WATTS

SCHEMATIC



DIAGRAM

TO-220 **CASE 221A** STYLE 1



MARKING

BUV27 = Device Code

= Assembly Location

= Year WW = Work Week G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping
BUV27G	TO-220 (Pb-Free)	50 per Rail

^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

BUV27

ELECTRICAL CHARACTERISTICS ($T_C = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
I _{CER}	Collector Cut–off Current (R _{BE} = 50 Ω)	V _{CE} = 240 V, T _C = 125°C			3.0	mA
I _{CEX}	Collector Cut-off Current	V _{CE} = 240 V, V _{BE} = -1.5 V, T _C = 125°C			1.0	mA
I _{EBO}	Emitter Cut-off Current (I _C = 0)	V _{BE} = 5 V			1.0	mA
V _{CEO(sus)}	Collector–Emitter Sustaining Voltage	I _C = 0.2 A, L = 25 mH	120			V
V _{EBO}	Emitter-Base Voltage (I _C = 0)	I _E = 50 mA	7.0		30	V
V _{CE(sat)} (Note 2)	Collector–Emitter Saturation Voltage	I _C = 4 A, I _B = 0.4 A I _C = 8 A, I _B = 0.8 A			0.7 1.5	V
V _{BE(sat)} (Note 2)	Base–Emitter Saturation Voltage	I _C = 8 A, I _B = 0.8 A			2.0	V
Resistive L	oad					
t _{on} t _s t _f	Turn-on Time Storage Time Fall Time	$V_{CC} = 90 \text{ V, } I_{C} = 8 \text{ A}$ $V_{BE} = -6 \text{ V, } I_{B1} = 0.8 \text{ A}$ $R_{BB} = 3.75 \Omega$		0.4 0.5 0.12	0.8 1.2 0.25	ms μs μs
Inductive Load						
t _s t _f	Storage Time Fall Time	$V_{CC} = 90 \text{ V, } I_{C} = 8 \text{ A}$ $I_{B1} = 0.8 \text{ A, } V_{BE} = -5 \text{ V}$ $L_{R} = 1 \mu \text{H}$		0.6 0.04		μS
t _s t _f	Storage Time Fall Time	$V_{CC} = 90 \text{ V}, I_{C} = 8 \text{ A}$ $I_{B1} = 0.8 \text{ A}, V_{BE} = -5 \text{ V}$ $L_{B} = 1 \mu\text{H}, T_{J} = 125^{\circ}\text{C}$			2.0 0.15	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 2. Pulsed: Pulse Duration = $300 \mu s$, Duty Cycle = 2%

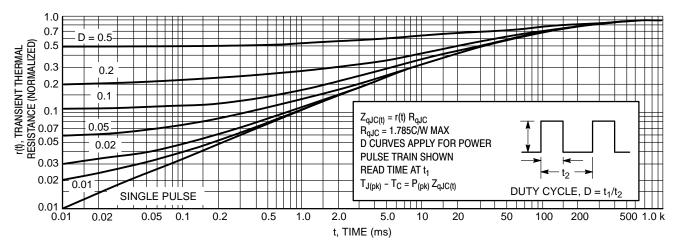
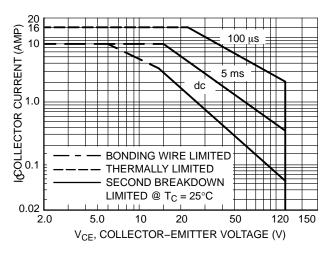


Figure 1. Thermal Response



There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation, i.e., the transistor must not be subjected to greater dissipation then the curves indicate.

The data of Figures 2 is based on $T_{J(pk)}=150^{\circ}C$; T_C is variable depending on conditions. Second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J(pk)}$ < 150°C. $T_{J(pk)}$ may be calculated from the data in Figure 1. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

Figure 2. Forward Bias Safe Operating Area

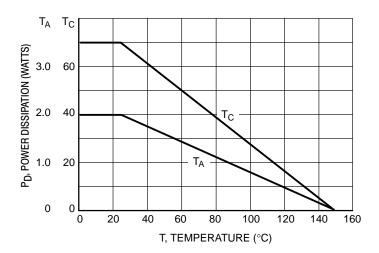
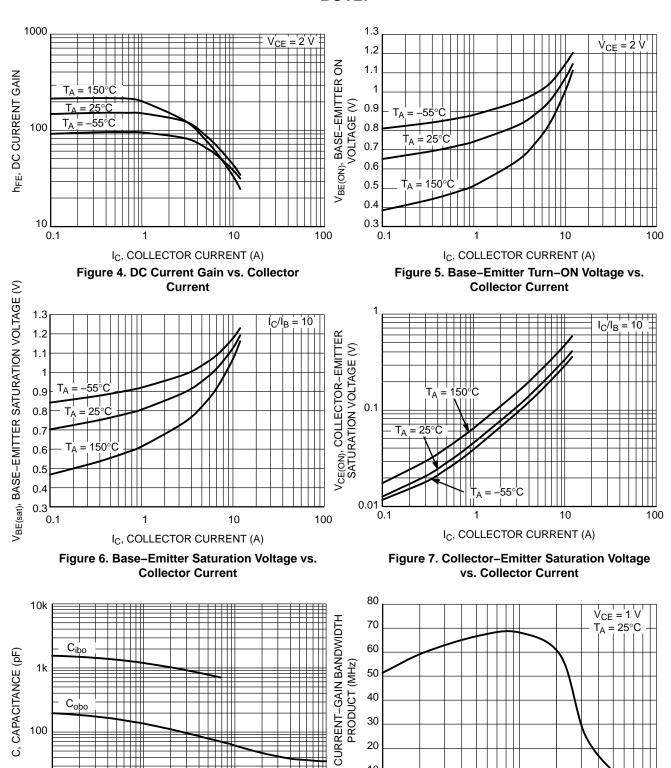


Figure 3. Power Derating



I_C, COLLECTOR CURRENT (A) Figure 9. Current Gain Bandwidth Product vs. **Collector Current**

1

10

100

10

1

V_R, REVERSE VOLTAGE (V) Figure 8. Capacitance

10

0.1

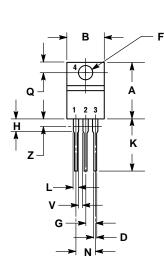
20 10

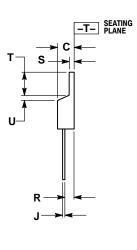
> 0 0.1

BUV27

PACKAGE DIMENSIONS

TO-220 CASE 221A-09 ISSUE AH





NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 2. CONTROLLING DIMENSION: INCH.
- DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.415	9.66	10.53
С	0.160	0.190	4.07	4.83
D	0.025	0.038	0.64	0.96
F	0.142	0.161	3.61	4.09
G	0.095	0.105	2.42	2.66
Н	0.110	0.161	2.80	4.10
J	0.014	0.024	0.36	0.61
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
Т	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

STYLE 1:

PIN 1. BASE

2. COLLECTOR

3. EMITTER

4. COLLECTOR

ON Semiconductor and the are registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale

N. American Technical Support: 800-282-9855 Toll Free

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA **Phone**: 303–675–2175 or 800–344–3860 Toll Free USA/Canada

Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

USA/Canada

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative